

PDFN5060 Plastic-Encapsulate MOSFETS

Features

- $V_{DS} = -30V$
- $I_D = -50A$
- $R_{DS(on)}@V_{GS} = -10V < 11.5m\Omega$
- $R_{DS(on)}@V_{GS} = -4.5V < 18m\Omega$
- Fast switching speed
- ROHS Compliant & Halogen-Free
- Surface mount package

Drain-source Voltage

-30 V

Drain Current

-50 Ampere

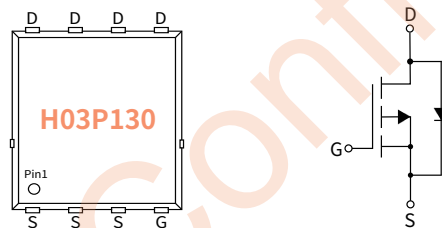
Applications

- Wireless impact
- Lithium battery protection
- Mobile phone fast charging

Mechanical Data

- Case: PDFN5060
Molding compound meets UL 94V-0 flammability rating, RoHS-compliant, halogen-free
- Terminals: Solder plated, solderable per MIL-STD-750, Method 2026

Function Diagram



Ordering Information

PACKAGE	PACKAGE CODE	UNIT WEIGHT(g)	REEL(pcs)	BOX(pcs)	CARTON(pcs)	DELIVERY MODE
PDFN5060	R3	0.09	5000	10000	50000	13"

Maximum Ratings (Ta=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	VALUE
Drain-source Voltage	V_{DS}	V	-30
Gate-source Voltage	V_{GS}	V	± 20
Drain Current	I_D	A	-50
Pulsed Drain Current ⁽¹⁾	I_{DM}	A	-160
Total Power Dissipation	P_D	W	31
Single pulse avalanche energy ⁽²⁾	EAS	mJ	72
Junction temperature	T_J	°C	-55 ~ +150
Storage temperature	T_{stg}	°C	-55 ~ +150
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	°C / W	4

● Static Parameter Characteristics (T_j=25°C Unless otherwise specified)

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA	V	-30	—	—
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V	μA	—	—	1.0
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} =0V	nA	—	—	±100
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	V	-1.0	-1.6	-2.5
Static Drain-Source On-Resistance ⁽³⁾	R _{DS(on)}	V _{GS} =-10V, I _D =-20A	mΩ	—	8.6	11.5
		V _{GS} =-4.5V, I _D =-10A		—	13.8	18

● Dynamic Parameters

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Input Capacitance	C _{iss}	V _{DS} =-15V, V _{GS} =0V, f=1MHZ	pF	—	1511	—
Output Capacitance	C _{oss}			—	252	—
Reverse Transfer Capacitance	C _{rss}			—	223	—

● Switching Parameters

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Turn-on Delay Time	t _{D(on)}	V _{GS} =-10V, V _{DD} =-15V, I _D =-20A, R _{GEN} =3Ω	nS	—	11	—
Turn-on Rise Time	t _r		nS	—	17	—
Turn-off Delay Time	t _{D(off)}		nS	—	60	—
Turn-off fall Time	t _f		nS	—	45	—
Total Gate Charge	Q _g	V _{DS} =-15V, I _D =-20A V _{GS} =-10V	nC	—	25	—
Gate-Source Charge	Q _{gs}		nC	—	4	—
Gate-Drain Charge	Q _{gd}		nC	—	5.5	—

● Drian-Source Diode Characteristics

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Diode Forward Voltage	V _{SD}	I _S =-50A, V _{GS} =0V	V	—	—	1.2
Maximum Body-Diode Continuous Current	I _S	—	A	—	—	-50
Reverse Recovery time	T _{rr}	I _{SD} =-50A di/dt=100A/us	nS	—	15	—
Reverse Recovery Charge	Q _{rr}		nC	—	6	—

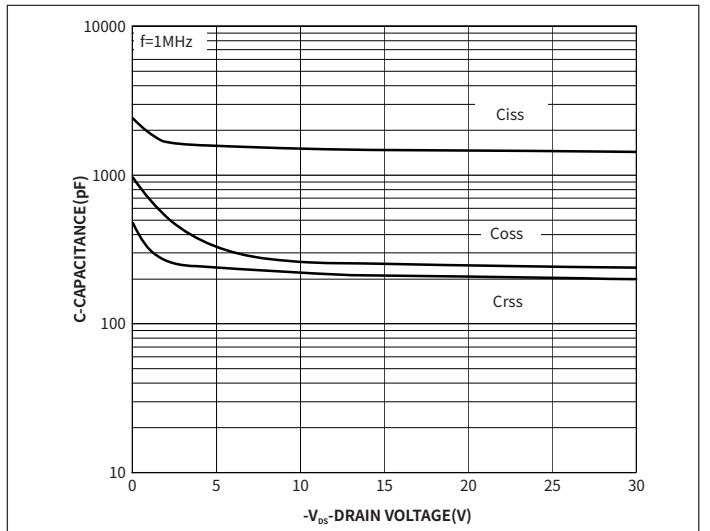
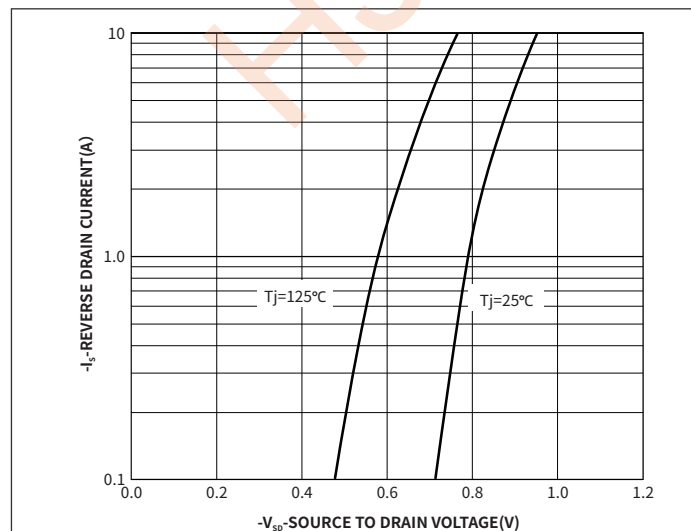
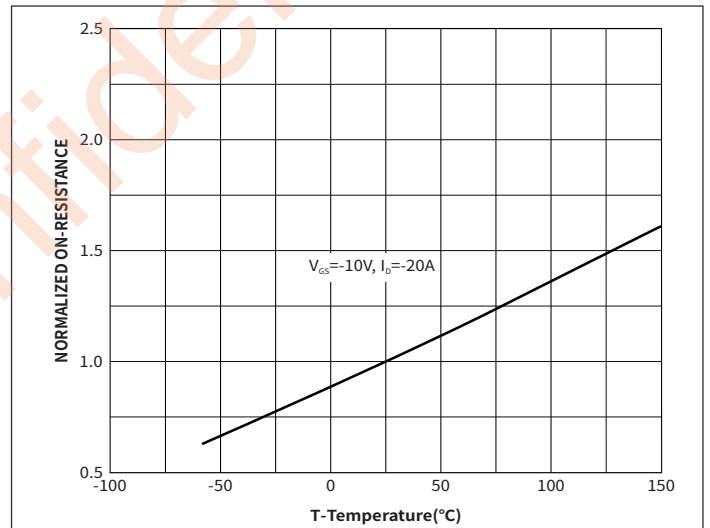
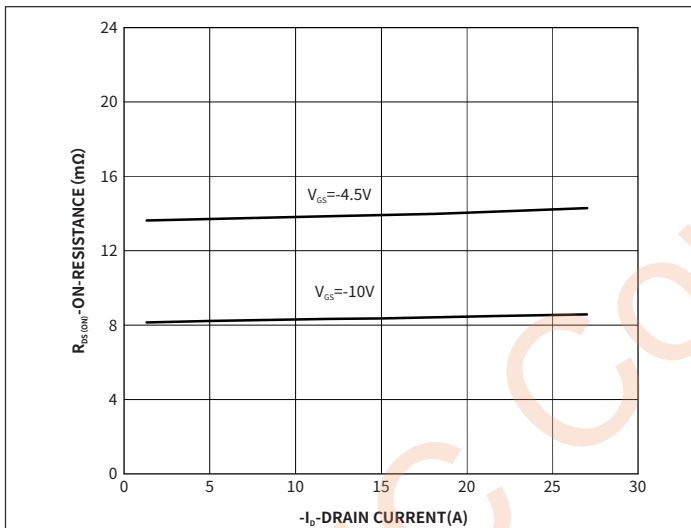
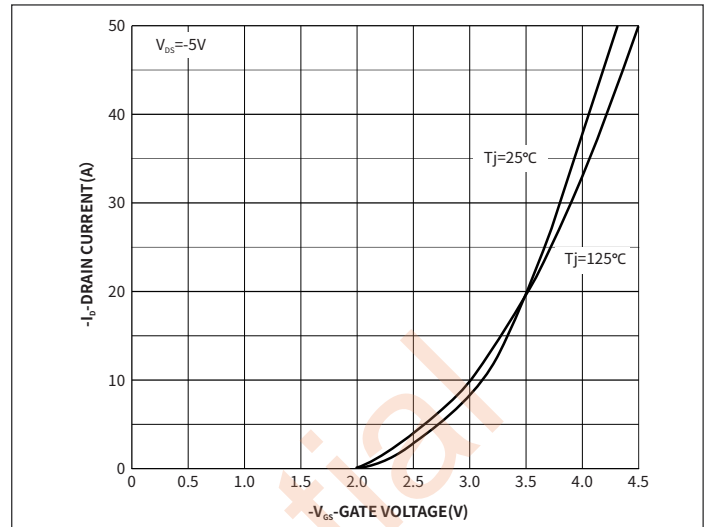
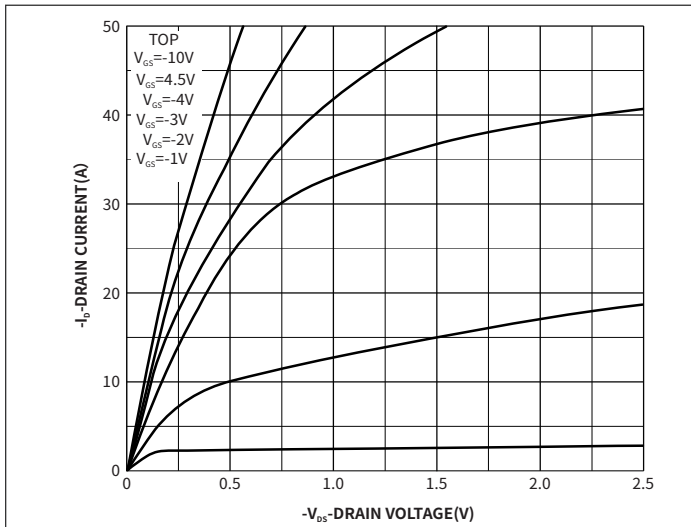
Note:

(1) Repetitive Rating: Pulse width limited by maximum junction temperature.

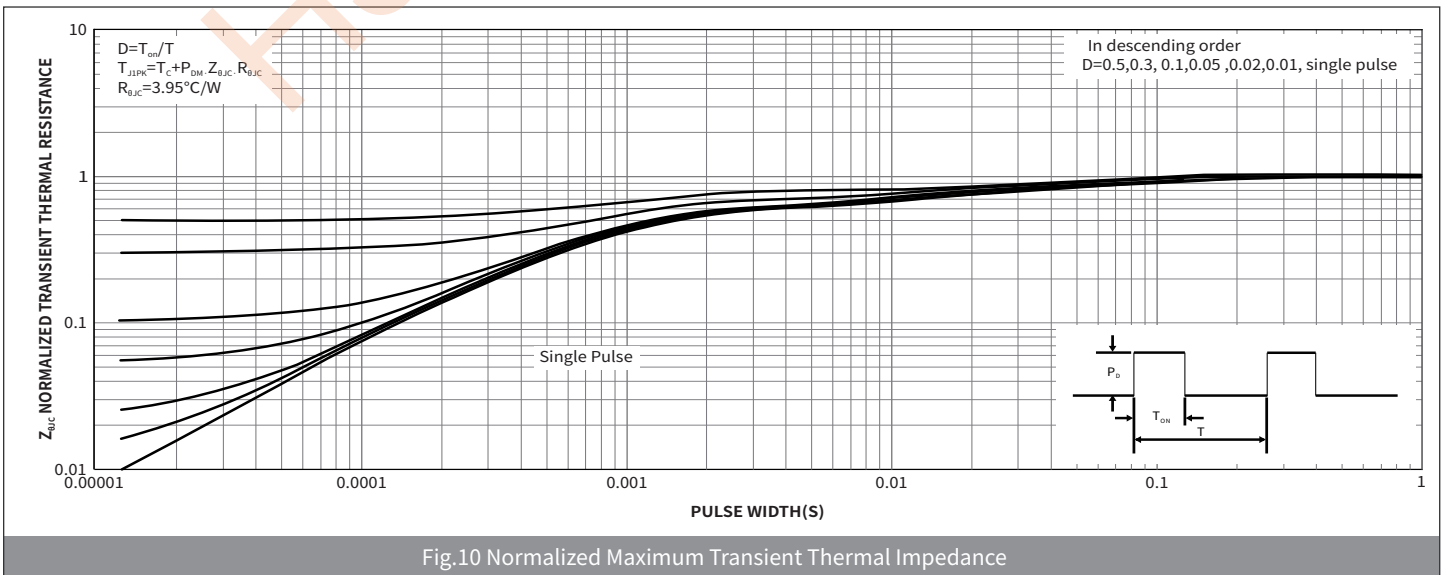
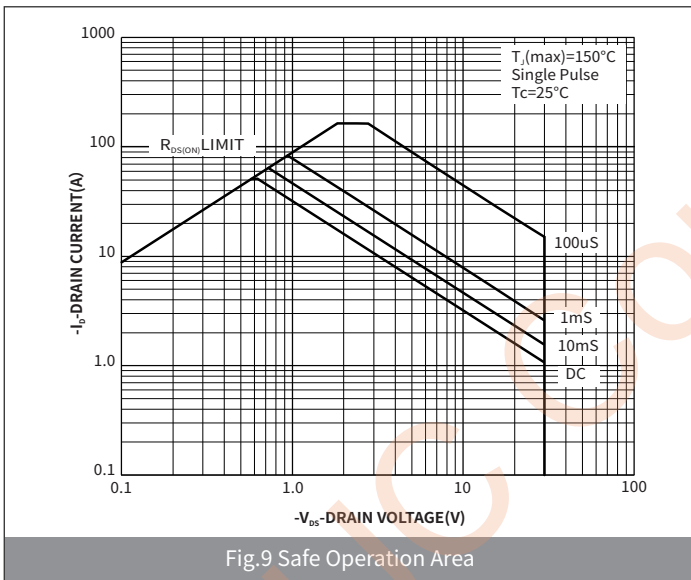
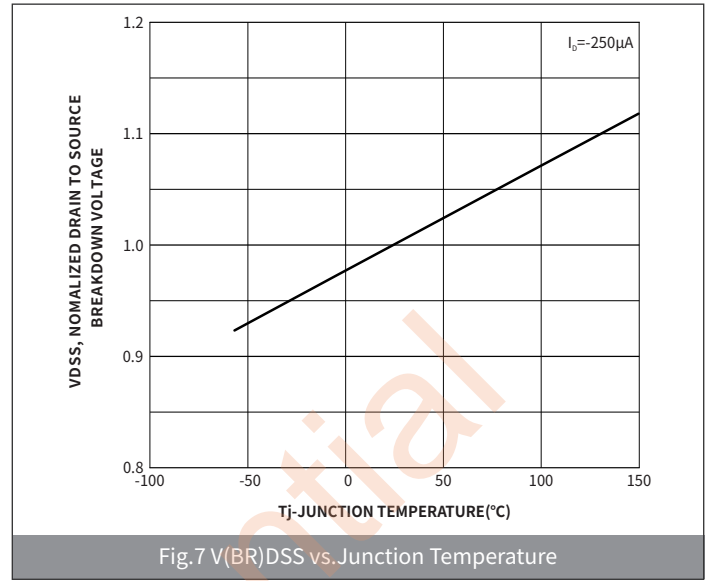
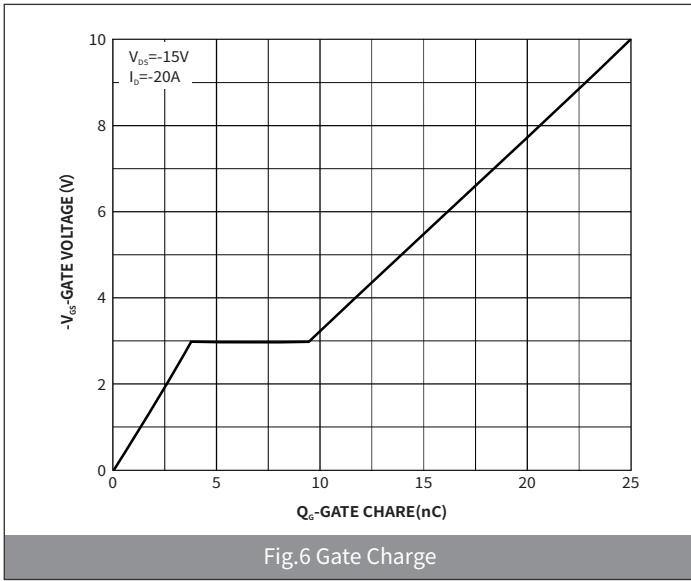
(2) EAS condition : T_j=25°C, V_{DD}=-15V, V_G=-10V, L=0.5mH, I_{AS}=-17A, R_G=25Ω.

(3) Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.

● Ratings And Characteristics Curves (Ta=25°C Unless otherwise specified)



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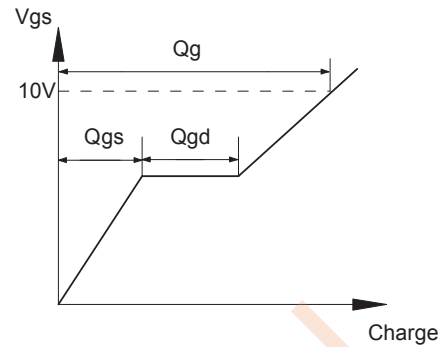
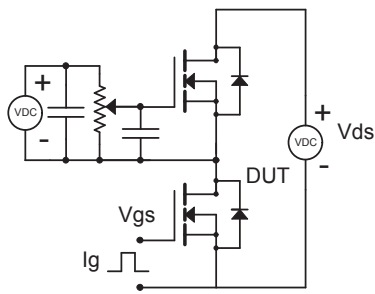
● Package Outline Dimensions (PDFN5060)

Symbol	Dimensions			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	0.90	1.05	0.035	0.041
b	0.35	0.45	0.014	0.018
C	0.20	0.30	0.008	0.012
D	4.85	5.15	0.190	0.203
D1	4.90	5.10	0.193	0.200
D2	4.10	4.30	0.161	0.169
e	1.17	1.37	0.046	0.054
E	5.85	6.13	0.230	0.241
E1	5.70	5.90	0.224	0.232
E2	3.35	3.65	0.132	0.144
H	0.50	0.72	0.020	0.029
K	1.19	1.39	0.047	0.056
L	0.56	0.75	0.022	0.030
L1	0.06	0.20	0.002	0.008
L2	-	0.12	-	0.005
N	0.40	0.60	0.016	0.024
θ	9°	13°	9°	13°

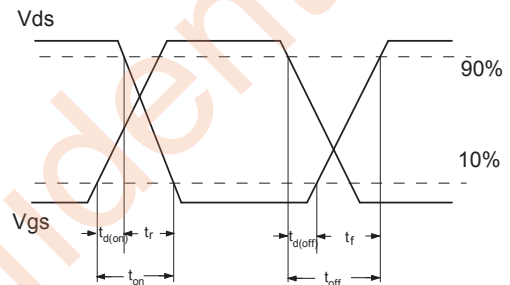
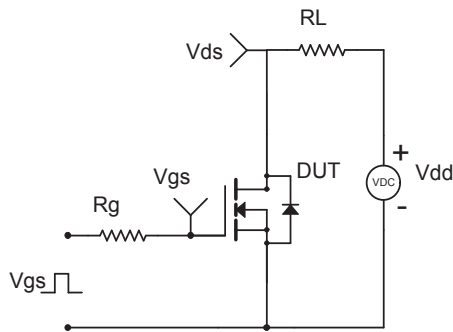
● Suggested Pad Layout

Symbol	Dimensions			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
a	0.46	0.48	0.0184	0.0192
B	0.70	0.90	0.028	0.036
C	1.17	1.37	0.0468	0.0548
G	0.75	0.95	0.03	0.038
G1	0.80	1.00	0.032	0.04
X	4.50	4.70	0.180	0.188
X1	0.70	0.90	0.028	0.036
Y	4.40	4.60	0.176	0.184
Y1	0.90	1.10	0.036	0.044

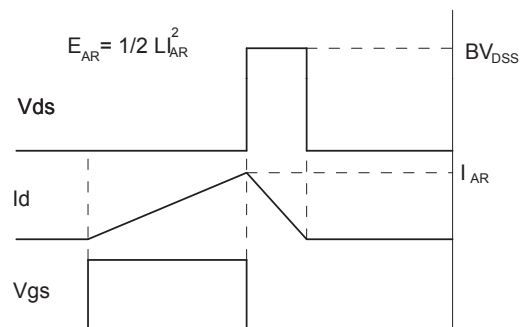
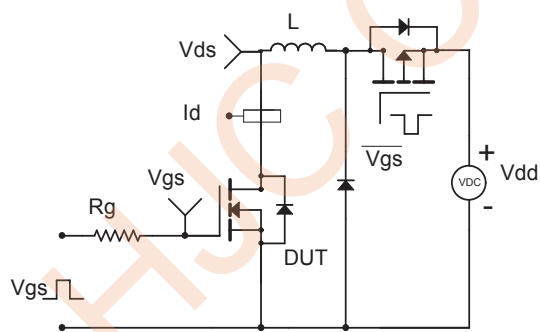
1. Gate Charge Test Circuit & Waveforms



2. Resistive Switching Test Circuit & Waveforms



3. Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



4. Diode Recovery Test Circuit & Waveforms

